Search Notes

Application/C	ontrol No.	Applicant(s)/Patent Reexamination	under
09/473,830		LEIDEN ET AL.	
Examiner		Art Unit	
Shin-Lin Che	n	1632	

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Class	Subclass	Date	Examiner
Updated		11/28/2005	4n
			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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